

PRODUCT RELIABILITY REPORT FOR

DS26401, Rev A2

Maxim Integrated Products

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Prepared by:

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Conclusion:

The following qualification successfully meets the quality and reliability standards required of all Maxim products:

In addition, Maxim's continuous reliability monitor program ensures that all outgoing product will continue to meet Maxim's quality and reliability standards. The current status of the reliability monitor program can be viewed at http://www.maxim-ic.com/TechSupport /dsreliability.html.

Device Description:

A description of this device can be found in the product data sheet. You can find the product data sheet at http://dbserv.maxim-ic.com/l_datasheet3.cfm.

Reliability Derating:

The Arrhenius model will be used to determine the acceleration factor for failure mechanisms that are temperature accelerated.

```
AfT = exp((Ea/k)*(1/Tu - 1/Ts)) = tu/ts
AfT = Acceleration factor due to Temperature
tu = Time at use temperature (e.g. 55°C)
ts = Time at stress temperature (e.g. 125°C)
k = Boltzmann's Constant (8.617 x 10-5 eV/°K)
Tu = Temperature at Use (°K)
Ts = Temperature at Stress (°K)
Ea = Activation Energy (e.g. 0.7 ev)
```

The activation energy of the failure mechanism is derived from either internal studies or industry accepted standards, or activation energy of 0.7ev will be used whenever actual failure mechanisms or their activation energies are unknown. All deratings will be done from the stress ambient temperature to the use ambient temperature.

An exponential model will be used to determine the acceleration factor for failure mechanisms, which are voltage accelerated.

```
AfV = exp(B*(Vs - Vu))

AfV = Acceleration factor due to Voltage

Vs = Stress Voltage (e.g. 7.0 volts)

Vu = Maximum Operating Voltage (e.g. 5.5 volts)

B = Constant related to failure mechanism type (e.g. 1.0, 2.4, 2.7, etc.)
```

The Constant, B, related to the failure mechanism is derived from either internal studies or industry accepted standards, or a B of 1.0 will be used whenever actual failure mechanisms or their B are unknown. All deratings will be done from the stress voltage to the maximum operating voltage. Failure rate data from the operating life test is reported using a Chi-Squared statistical model at the 60% or 90% confidence level (Cf).

The failure rate, Fr, is related to the acceleration during life test by:

```
Fr = X/(ts * AfV * AfT * N * 2)
X = Chi-Sq statistical upper limit
N = Life test sample size
```

Failure Rates are reported in FITs (Failures in Time) or MTTF (Mean Time To Failure). The FIT rate is related to MTTF by:

MTTF = 1/Fr

NOTE: MTTF is frequently used interchangeably with MTBF.

The calculated failure rate for this device/process is:

FAILURE RATE: MTTF (YRS): 254428 FITS: 0.4

DEVICE HOURS: 2165280 FAILS: 0

Only data from Operating Life or similar stresses are used for this calculation.

The parameters used to calculate this failure rate are as follows:

Cf: 60% Ea: 0.7 B: 0 Tu: 25 °C Vu: 3.5 Volts

The reliability data follows. At the start of this data is the device information. The next section is the detailed reliability data for each stress. The reliability data section includes the latest data available and may contain some generic data. "*" after DATE CODE denotes specific product data and SEQ No. to identify specific line items in the report for comments when required.

Device Information:

Process: 2P, 4M,0.35um,Sil.P1,P2Cap,Ti/TiN M1-M4,BPSG,Masked N+ESD,

Passivation: Passivation w/Nov TEOS Oxide-Nitride

Die Size: 393 x 392

Number of Transistors: 0

Interconnect: Aluminum / 0.5% Copper

Gate Oxide Thickness: 75 Å

ELECTRICAL CHARACTERIZATION

DESCRIPTION	DATE (DATE CODE/SEQ CONDITION			ADPOINT	QTY	FAILS	FA#
ESD SENSITIVITY	0324	* 1	EOS/ESD S5.1 HBM 500 VOLTS	1	PUL'S	3	0	
ESD SENSITIVITY	0324	* 2	EOS/ESD S5.1 HBM 1000 VOLTS	1	PUL'S	3	0	
ESD SENSITIVITY	0324	* 3	EOS/ESD S5.1 HBM 2000 VOLTS	1	PUL'S	3	0	
LATCH-UP	0324	* 6	JESD78, I-TEST 125C			6	0	
LATCH-UP	0324	* 7	JESD78, V-SUPPLY TEST 125C			6	0	
					Total:		0	

OPERATING LIFE						
DESCRIPTION	DATE CODE/SEQ	CONDITION	READPOINT	QTY	FAILS	FA#
HIGH VOLTAGE LIFE	0131	125C, 3.5 VOLTS	1000 HRS	77	0	
HIGH VOLTAGE LIFE	0134	125C, 3.5 VOLTS	1000 HRS	77	0	
HIGH VOLTAGE LIFE	0150	125C, 3.5 VOLTS	1000 HRS	77	0	
HIGH VOLTAGE LIFE	0213	125C, 3.5 VOLTS	1000 HRS	71	0	
HIGH VOLTAGE LIFE	0222	125C, 3.5 VOLTS	1000 HRS	45	0	
HIGH VOLTAGE LIFE	0233	125C, 3.5 VOLTS	1000 HRS	77	0	
HIGH VOLTAGE LIFE	0234	125C, 3.5 VOLTS	1000 HRS	45	0	

HIGH TEMP OP LIFE	0317		125C, 3.5 VOLTS	1000	HRS	45	0
HIGH VOLTAGE LIFE	0332	* 1	125C, 3.5 VOLTS	1000	HRS	42	0
HIGH TEMP OP LIFE	0403		125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0417		125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0418		125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0425		125C, 3.5 VOLTS	1000	HRS	44	0
HIGH TEMP OP LIFE	0436		125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0440		125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0442		125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0447		125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0448		125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0501		125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0518		125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0520		125C, 3.5 VOLTS	1000	HRS	44	0
HIGH TEMP OP LIFE	0525		125C, 3.5 VOLTS	1000	HRS	77	0
HIGH TEMP OP LIFE	0527		125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0536		125C, 3.5V (PSA) & 2.0V (PSB)	1000	HRS	45	0
HIGH TEMP OP LIFE	0537		125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0542		125C, 3.5 VOLTS	192	HRS	45	0
HIGH TEMP OP LIFE	0548		125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0604		125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0606	* 6	125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0614	* 5	125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0616	* 5	125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0616	* 5	125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0616	* 5	125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0617		125C, 3.6 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0617		125C, 3.6 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0617		125C, 3.6 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0618		125C, 3.5 VOLTS	1000	HRS	77	0
HIGH TEMP OP LIFE	0620		125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0632		125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0632		125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0641		125C, 3.5 VOLTS	1000	HRS	45	0
HIGH TEMP OP LIFE	0650		125C, 3.5 VOLTS	1000	HRS	45	0

FAILURE RATE:		MTTF (YRS):	254428	FITS:		0.4		
					•	Total:		0
HIGH TEMP OP LIFE	0716	125C, 3.5 VOLTS				HRS	45	0
HIGH TEMP OP LIFE	0706	125C, 3.5V (PSA) & 2.0V (PSB)				HRS	45	0
HIGH TEMP OP LIFE	0650	125C, 3.5 V	1000	HRS	45	0		

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DEVICE HOURS: 2165280 FAILS: 0